

Student

Sophisticated Instrument Facility & Department of Metallurgical and Materials Engineering National Institute of Technology Tiruchirappalli-620015

Requisition form for

X-ray Diffraction Analysis (for NIT users only)

	A Tay D	iniaction Analysis (for 1411)	ASCIS OIII	<u>u</u>	
<u>User Info</u>	ormation				
Name of the NITT student:			E-mai	E-mail:	
B. Tech/M. Tech/MSc/MS/PhD:			Phone	Phone No:	
Name of the Faculty/ Student's guide:			E-mai	E-mail:	
Departm	ent:				
Sample a	and Measurement Det	<u>ails</u>			
Scan range (2θ range): Step size:					
Purpose	of XRD-phase identifica	ation, quantification, crystal size me	asurement,	any other:	
Reference	e XRD pattern/JCPDS N	lo –available/not available:			
No of sai	mples: (n	naximum 2 samples in one slot)			
Solid san	nples: Flat samples with	n size ≤ 10 mm diameter or 10 mm	square. Thic	ckness <4 mm;	
Powder	samples: fine powder				
Sl. No	Sample code	Chemical name and formu	ıla	Any other details	
1.					
2.					
Signatur	es				
	<u></u>	les submitted for XRD belong to th	e NITT user	mentioned above and	
t	he measurements can	be performed without any charges.			
 Certified that the samples submitted for XRD are non-toxic. 					
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Students Guide/Faculty

Head of the Department